

<b>Notice of References Cited</b>	Application/Control No. 10/526,520		Applicant(s)/Patent Under Reexamination SCHULIST ET AL.	
	Examiner HAI V. NGUYEN		Art Unit 2618	Page 1 of 2

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	Examiner HAI V. NGUYEN		Art Unit 2618	Page 2 of 2

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